

Mini-spectrometers



[**TG series**]

C9913GC

C9914GB

**For near IR, integrating optical system,
image sensor and circuit**

Hamamatsu TG series mini-spectrometers C9913GC, C9914GB are polychromators integrated with optical elements and an image sensor. Light to be measured is guided into the entrance port of TG series through an optical fiber and the spectrum measured with the built-in image sensor is output from the USB port to a PC for data acquisition. The C9913GC and C9914GB allow accurate measurement with low noise by cooling the image sensor. The C9913GC and C9914GB come supplied with evaluation software that allows setting measurement conditions, acquiring and saving data, and displaying graphs. Original measurement software can be designed on an end-user's side as DLL's function specification is disclosed.

Features

- High throughput due to transmission grating made of quartz
- Highly accurate optical characteristics
- Low noise
- Compact design for easy assembly
- Wavelength conversion factor*1 is recorded in internal memory

Applications

- Water content measurement
- Component analysis in food, agriculture fields, etc.
- Process control for chemical products
- Plastic sorting

*1: A conversion factor for converting the image sensor pixel number into a wavelength is recorded in the module. A calculation factor for converting the A/D converted count into the input light level is not provided.

Optical characteristics

Parameter	TG-cooled NIR-I	TG-cooled NIR-II	Unit
	C9913GC	C9914GB	
Spectral response range	900 to 1700	1100 to 2200	nm
Spectral resolution (FWHM)*2	7 max.	8 max.	nm
Wavelength reproducibility*3	-0.2 to +0.2	-0.4 to +0.4	nm
Wavelength temperature dependence	-0.02 to +0.02	-0.04 to +0.04	nm/°C
Spectral stray light*2 *4	-35 max.		dB

*2: Depends on the slit opening. Values were measured with the slit listed in the table "Structure".

*3: Measured under constant light input conditions

*4: When monochromatic light of the following wavelengths is input, spectral stray light is defined as the ratio of the count measured at the input wavelength, to the count measured in a region of the input wavelength ± 40 nm.

C9913GC: 1300 nm, C9914GB: 1650 nm

Electrical characteristics

Parameter	C9913GC	C9914GB	Unit
A/D conversion	16		bit
Integration time	5 to 10000	5 to 1000	ms
Interface	USB 1.1		-
Current consumption of USB bus power	250 max.		mA

Structure

Parameter	C9913GC	C9914GB	Unit
Dimensions (W × D × H)	142 × 218 × 82		mm
Weight	1700		g
Image sensor	TE-cooled type InGaAs linear image sensor (G9204-512S)	TE-cooled type InGaAs linear image sensor	-
Number of pixels*5	512	256	pixels
Slit*6 (H × V)	70 × 500		μm
NA*7	0.22		-
Connector for optical fiber	SMA905D		-
Current consumption for cooling element (+5 V)*8	1.8 max.	2.8 max.	A
Current consumption for cooling fan (+12 V)*8	0.2 max.		A

*5: No defective pixel (when inspecting at low gain). Defective pixels are those whose electrical and optical characteristics do not meet our specifications.

*6: Entrance slit aperture size

*7: Numeric aperture (solid angle)

*8: Maximum value in steady state. Note that inrush current flows at start-up.

The connector for connection to cooling element and cooling fan power supply is attached.

Absolute maximum ratings

Parameter	C9913GC	C9914GB	Unit
Operating temperature*9	+5 to +35 (+5 to +30*10)		°C
Storage temperature*9	-20 to +70		°C

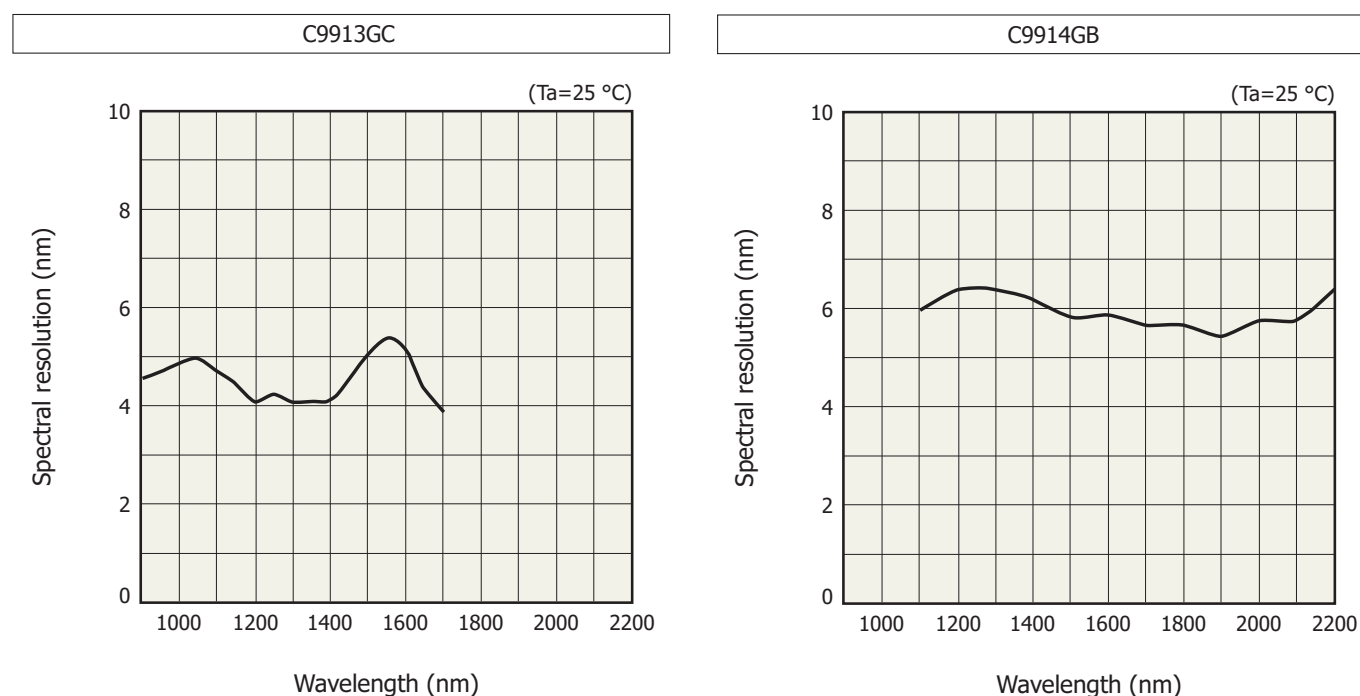
*9: No dew condensation

When there is a temperature difference between a product and the surrounding area in high humidity environment, dew condensation may occur on the product surface. Dew condensation on the product may cause deterioration in characteristics and reliability.

*10: For controllable cooling temperature

Note: Exceeding the absolute maximum ratings even momentarily may cause a drop in product quality. Always be sure to use the product within the absolute maximum ratings.

Spectral resolution vs. wavelength (typical example)

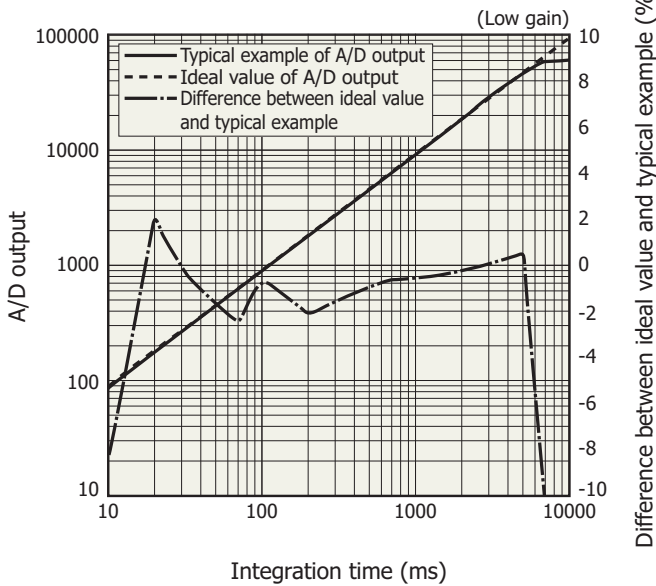


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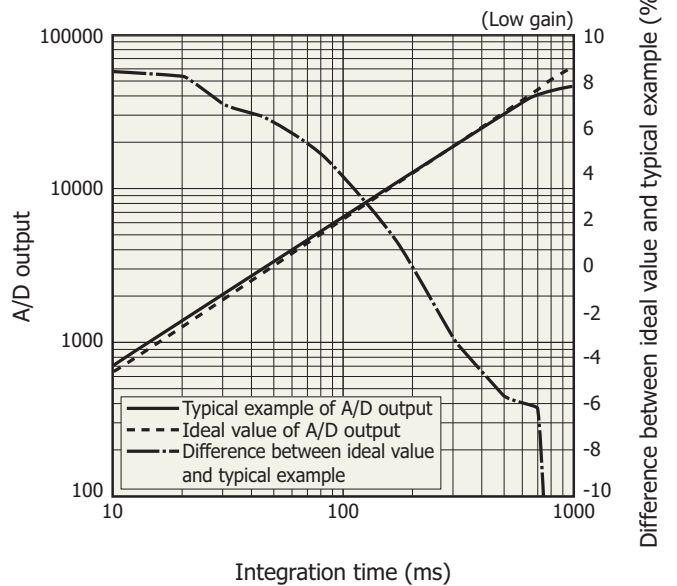
Linearity (typical example)

C9913GC



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C9914GB

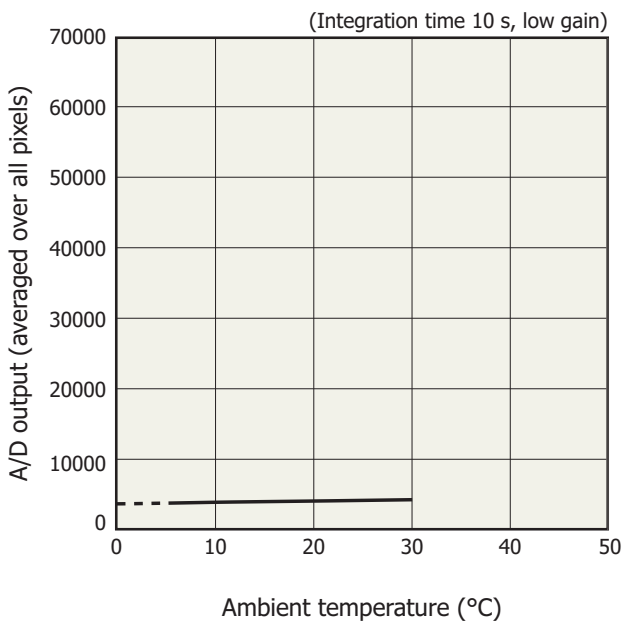


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A/D output is the output with dark output is subtracted when light is input. The difference between the ideal value and typical example contains a measurement error. The smaller the A/D output, the larger the measurement error.

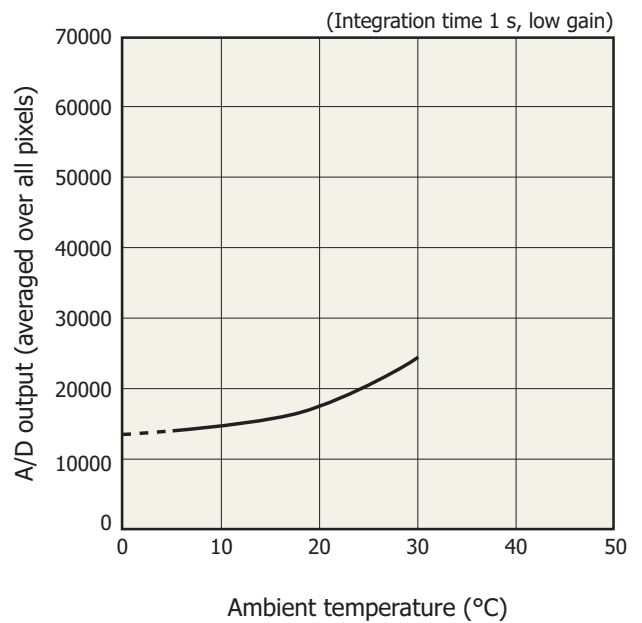
Dark output vs. ambient temperature (typical example)

C9913GC



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C9914GB

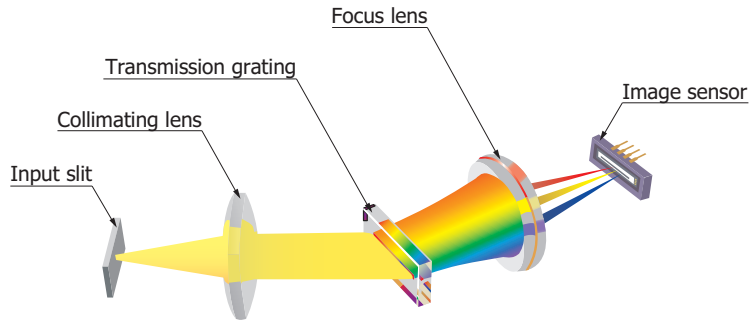


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A/D output is the sum of the sensor and circuit offset outputs and the sensor dark output.

Optical component layout

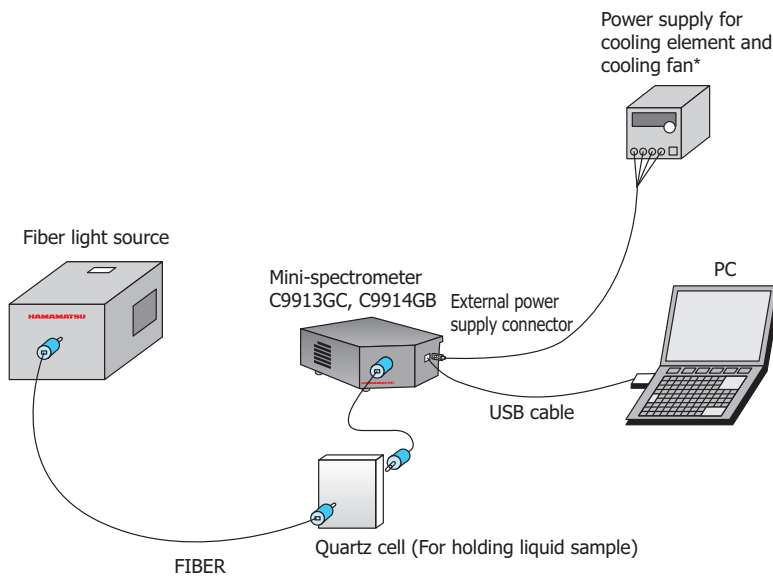
TG series mini-spectrometers use a transmission holographic grating made of quartz and precision optical components arranged on a rugged optical base, making it possible to deliver high throughput and highly accurate optical characteristics.



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Connection example (transmission light measurement)

Light to be measured is guided into the entrance port of TG series through an optical fiber and the spectrum measured with the built-in image sensor is output through the USB port to a PC for data acquisition. There are no moving parts inside the unit so stable measurements are obtained at all times. An optical fiber that guides light input from external sources allows a flexible measurement setup.



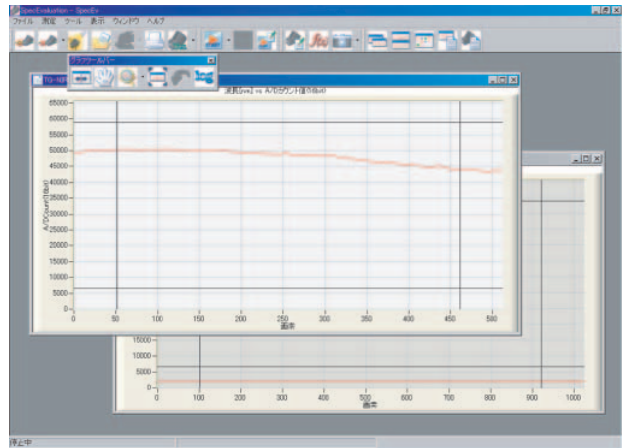
* External power supply should be prepared by the user.

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❑ Evaluation software package (supplied with unit)

Installing the evaluation software package (Spec Evaluation.exe)*11 into your PC allows running the following basic tasks:

- Measurement data acquisition and save
- Measurement condition setup
- Module information acquisition
(wavelength conversion factor, polychromator type, etc.)
- Graphic display
- Arithmetic operation
 - Pixel number to wavelength conversion
 - Comparison calculation with reference data
(transmittance, reflectance)
 - Dark subtraction
 - Gaussian approximation
(peak position and count, FWHM)



Note:

- Two or more mini-spectrometers can be connected and used with one PC simultaneously.
- The external trigger input function does not work with the evaluation software. If using an external trigger input or designing original application software, the user software must be configured to support that function.

*11: Compatible OS: Microsoft® Windows® 7 Professional SP1 (32-bit, 64-bit)
Microsoft Windows 8 Professional (32-bit, 64-bit)
Microsoft Windows 10 Professional (32-bit, 64-bit)

DLL for controlling hardware is also provided.

You can develop your own measurement programs by using a following software development environment.

Microsoft Visual Studio® 2008 (SP1) Visual C++®

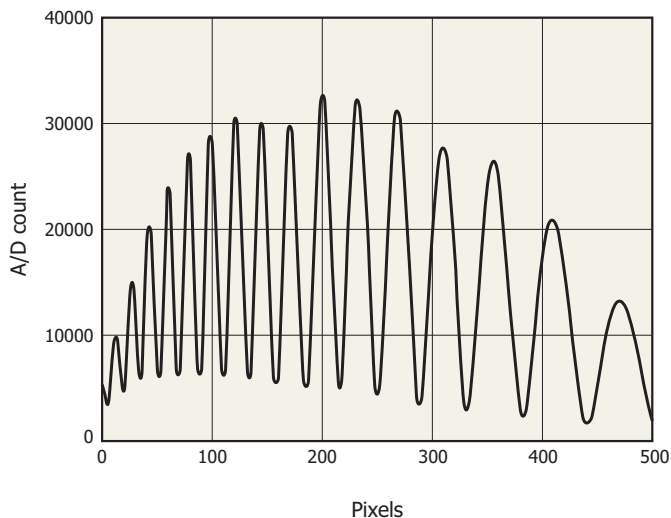
Microsoft Visual Studio 2008 (SP1) Visual Basic®

Note: Microsoft, Windows, Visual Studio, Visual C++ and Visual Basic are either registered trademarks or trademarks of Microsoft Corporation in the United States and other countries.

❑ Measurement example

Film thickness measurement (white light interferometry)

Thickness of 10 μm thick food wrapping film (polyvinylidene chloride) was measured.



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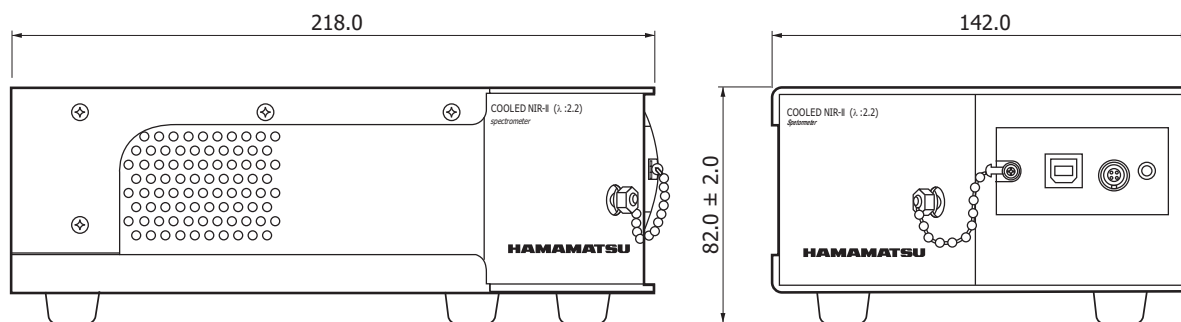
Note:

Principle of film thickness measurement:

In film thickness measurement utilizing white light interferometry, an interference spectrum resulting from internal reflections between the front and back surfaces of a film is obtained.

The film thickness can then be determined by calculation from the spectral peak count, wavelength range, refractive index of film and incident light angle.

Dimensional outlines (unit: mm)



Tolerance unless otherwise noted: ± 1.0
Weight: 1.7 kg

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Accessories

- USB cable
- Dedicated software (evaluation software, sample software, DLL)
- External power supply connector [made by LEMO S.A.: FGG0B304CLAD56 (only available in C9913GC and C9914GB)]

Options (sold separately)

- Optical fiber for light input

Type no.	Product name	Core diameter (μm)	Specification
A9763-01	Fiber for visible/near infrared range	600	NA=0.22, length 1.5 m, connectorized SMA905D at both ends

Mini-spectrometer lineup

Type no.	Type	Spectral response range (nm)													Spectral resolution max. (nm)	Image sensor			
		200	400	600	800	1000	1200	1400	1600	1800	2000	2200	2400	2600					
C10082CA	TM-UV/VIS-CCD High sensitivity																	6	Back-thinned CCD image sensor
C10082CAH	TM-UV/VIS-CCD High resolution		200 to 800															1*	
C10082MD	TM-UV/VIS-MOS Wide dynamic range																	6	CMOS linear image sensor
C10083CA	TM-VIS/NIR-CCD High sensitivity																	8 (λ=320 to 900 nm)	Back-thinned CCD image sensor
C10083CAH	TM-VIS/NIR-CCD High resolution																	1* (λ=320 to 900 nm)	
C10083MD	TM-VIS/NIR-MOS Wide dynamic range																	8	CMOS linear image sensor
C11697MB	TM-VIS/NIR-MOS-II Trigger-compatible																	8	High-sensitivity CMOS linear image sensor
C9404CA	TG-UV-CCD High sensitivity		200 to 400															3	Back-thinned CCD image sensor
C9404CAH	TG-UV-CCD High resolution		200 to 400															1*	
C9405CB	TG-SWNIR-CCD-II IR-enhanced																	5 (λ=550 to 900 nm)	IR-enhanced back-thinned CCD image sensor
C11713CA	TG-RAMAN-I High resolution																	0.3*	Back-thinned CCD image sensor
C11714CB	TG-RAMAN-II High resolution																	0.3*	IR-enhanced back-thinned CCD image sensor
C11482GA	TG2-NIR Non-cooled type																	7	InGaAs linear image sensor
C9913GC	TG-cooled NIR-I Low noise (cooled type)																	7	
C9914GB	TG-cooled NIR-II Low noise (cooled type)																	8	
C11118GA	TG-cooled NIR-III Low noise (cooled type)																	20	
C13053MA	TF-SWIR-MOS-II Compact, thin case																	3.5	High-sensitivity CMOS linear image sensor
C13054MA	TF-RAMAN Compact, thin case																	0.4*	
C13555MA	TF-VIS-MOS-II Compact, thin case																	3	
C11007MA	RC-VIS-MOS Spectrometer module																	9	CMOS linear image sensor
C11008MA	RC-SWNIR-MOS Spectrometer module																	8	IR-enhanced CMOS linear image sensor

* Typ.

For installation into mobile measuring equipment

Type no.	Type	Spectral response range (nm)													Spectral resolution max. (nm)	Image sensor			
		200	400	600	800	1000	1200	1400	1600	1800	2000	2200	2400	2600					
C11009MA	RC-VIS-MOS Spectrometer head																	9	CMOS linear image sensor
C11010MA	RC-SWNIR-MOS Spectrometer head																	8	IR-enhanced CMOS linear image sensor

For installation into mobile measuring equipment (ultra-compact)

Type no.	Type	Spectral response range (nm)													Spectral resolution max. (nm)	Image sensor			
		200	400	600	800	1000	1200	1400	1600	1800	2000	2200	2400	2600					
C11708MA	MS-SWNIR-MOS Spectrometer head																	20	CMOS linear image sensor
C12666MA	Spectrometer head																	15	CMOS linear image sensor
C12880MA	Spectrometer head																	15	High-sensitivity CMOS linear image sensor

Related information

http://www.hamamatsu.com/sp/ssd/doc_en.html

■ Precautions

- Disclaimer
- Mini-spectrometers

■ Technical information

- Mini-spectrometers

Information described in this material is current as of December 2017.

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